

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/806,682	ROWE ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Pablo N. Tran	2618	

SEARCHED			
Class	Subclass	Date	Examiner
988	11A.2	01/27/66	JP2
29.6			
63.1			
63.3			
67.13			
6.8			
78			
83			
580.1			
560			
91			
118.1			
168.1			
170.1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East / West	07/27/06	SL
Cong Ho	07/27/06	L

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
455	144.2	07/27/08	PL
307			
293			
266			
306			

**Search Notes (continued)**

Application/Control No.

10/806,682

Examiner

Pablo N. Tran

Applicant(s)/Patent under  
Reexamination

ROWE ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
		191.3 01/07/06	P
213			
293			
299			
306			
307			
339			
583.1			
266			
278.1			
379	416-417		
375	316		
370	343		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner